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|-----------------------------------|--|-------------------------|---|---------------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/593,297 HAN ET AL. | |
| | | Examiner | Art Unit HARRY LIU | 3662 Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,101,176 A | 08-2000 | Honkasalo et al. | 370/335 |
| * | B | US-6,501,955 B1 | 12-2002 | Durrant et al. | 455/456.1 |
| * | C | US-2003/0008669 A1 | 01-2003 | Stein et al. | 455/456 |
| * | D | US-2003/0054813 A1 | 03-2003 | Riley et al. | 455/424 |
| * | E | US-2003/0125045 A1 | 07-2003 | Riley et al. | 455/456 |
| * | F | US-6,665,539 B2 | 12-2003 | Sih et al. | 455/456.3 |
| * | G | US-2004/0121774 A1 | 06-2004 | Rajkotia et al. | 455/441 |
| * | H | US-2004/0165657 A1 | 08-2004 | Simic et al. | 375/211 |
| * | I | US-2004/0219930 A1 | 11-2004 | Lin, Ie-Hong | 455/456.1 |
| * | J | US-7,039,418 B2 | 05-2006 | Amerga et al. | 455/456.1 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.